


<b>Search Notes</b> 	<b>Application/Control No.</b> 10523525	<b>Applicant(s)/Patent Under Reexamination</b> MAEGAWA ET AL.
	<b>Examiner</b> ASIF H KHAN	<b>Art Unit</b> 4183

SEARCHED			
Class	Subclass	Date	Examiner
370	248, 254, 255, 332, 351	02/11/2008	Asif H. Khan

SEARCH NOTES		
Search Notes	Date	Examiner
STIC EIC PLUS	02/05/2008	Asif H. Khan
EAST (Text Search Attached)	02/11/2008	Asif H. Khan

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner